

<b>Notice of References Cited</b>	Application/Control No. 10/564,790	Applicant(s)/Patent Under Reexamination KOBAYASHI ET AL.	
	Examiner Nguyen T. Ha	Art Unit 2831	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-6,765,784	07-2004	Ohya et al.	361/523
*	C	US-6,552,896	04-2003	Igaki et al.	361/523
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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